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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/791,510	SHIN ET AL.	
Examiner	Art Unit	
Linh T. Nguyen	2627	

SEARCHED					
Class	Subclass	Date	Examiner		
369	112.12	12/8/2006	LN		
369	112.07	12/8/2006	LN		
369	112.04	12/18/2006	LN		
369	112.1	12/8/2006	LN		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	e Search on ast.	12/8/2006	LN	

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		DATE	EXMR	
East Searched.		12/8/2006	LN	
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